277634US6YA PCT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

GarveSCHER, et al.

SERIAL NO:

10/550.416

FILED:

September 23 2005

FOR:

A METHOD FOR ADJOINING ADJACENT COATINGS ON A PROCESSING ELEMENT

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR

Applicant(s) wish to disclose the following information.

RÉFERENCES

The applicant(s) wish to make of record the references listed on the attached form PTO-1449, which include references cited in the applications listed in Appendix A and not previously cited in the present application. Copies of the listed references are attached, where required, as are English language abstracts and translations for the non-English references. Applicants also wish to make of record the International Search Reports, PCT Written Opinions, Statement of Relevancy and U.S. Office Actions noted in Appendix A.

☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.

A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

- Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- □ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number <u>15-0030</u>. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND,

MAIER & NEUSTADT, P.C.

Steven P. Weihrouch

Registration No. 32,829

Customer Number

22850

Tel. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 05/03)

Edwin D. Garlepp Registration No. 45,330

(CSMMIN 05/05) I:\ATTY\EDG\2312 - TOKYO ELECTRON\PC\PC 6037A\277634US\277634US - IDS 5-12-06.DOC IFO, made



DOCKET NO.: 200633US0

page 1 of 1

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Hayashi OTSUKI

SERIAL NO.: New Application

FILED:

Herewith

FOR: PROCESSING APPARATUS WITH A CHAMBER HAVING THEREIN A HIGH-CORROSION-RESISTANT SPRAYED FILM

STATEMENT OF RELEVANCY

Reference AA (4,469,619) on Form PTO-1449:

This patent discloses a method of manufacturing a green phosphor.

Reference AB (5,426,310) on Form PTO-1449:

This patent discloses an apparatus and a method of heat-treating an oxide optical crystal ($Ti_3Al_5O_{12}$ is one of materials of magnetic garnet).

Reference AO (8-81777) on Form PTO-1449:

This publication discloses an apparatus and a method for forming a TiN film by plasma CVD.

Reference AP (8-268751) on Form PTO-1449:

This publication discloses sintered YAG (yttrium/aluminium/garnet) powder whose X-ray diffraction strength ratio is equal to or larger than 0.5, and a method for producing the same.

Reference AQ (7-226378) on Form PTO-1449:

This publication discloses an apparatus and a method for forming a Ti/TiN film by helicon wave plasma.

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LIST OF RE	FEREN	ICES CITED BY	APPLICANT	Gary ESCHER, et al.				
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				September 23, 2005 FOREIGN PATENT DOCUMENTS	<u> </u>			
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EXAMINER		DOCUMENT	DATE	COUNTRY	TRANSL	ATION		
INITIAL		NUMBER	DATE		YES	NO		
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-	AB	10-004083	01/06/1998	Japan (w/ English abstract and computer translation)	×			
	AC	2001-226773	08/21/2001	Japan (w/ English abstract; corresponding to US 2001/0003271 A1)	<u> </u>	x		
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	AQ	4-238882	08/1992	Japan (w/ certified English translation)	x			
	AR	1-312087	12/1989	Japan (w/ English abstract; corresponding to US Patent 4,968,374)		×		
	AS	08-041309	02/1996	Japan (w/ English abstract and computer translation)	×			
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LIST OF	REFEF	RENCES CITED BY API	PLICANT	Gary ESCHER, et al.				
				FILING DATE		GROUP		
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	AA	6,894,769	05/2005	Ludviksson et al.	:			
	AB	6,875,477	04/2005	Trickett et al.				
	AC	6,852,433	02/2005	Maeda, Takao				
	AD	6,833,279	12/2004	Choi, Jin-Sik				
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	AY	2004/0168640A1	09/2004	Muto, et al.		1 -		
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	AA	4,842,683	06/1989	Cheng et al.				
	AB	6,663,714	12/203	Mizuno et al.				
	AC	6,726,801	04/2004	Ahn, Jae-Su		,		
	AD	6,562,186	05-2003	Saito et al.	156	345.24	- "	
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	ВА	2005/0103275	02-2004	Sasaki et al.				
	ВВ	4,310,390	01-1982	Bradley et al.				
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	AB	5,879,575	3/1999	Tepman et al.				
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	АН	6,120,640	9/2000	Shih et al.				
<u> </u>	Al	6,738,862	5/2004	Ross et al.				
-	AJ	6,783,863	8/2004	Harada et al.				
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	AT	5,551,190	9/1996	Yamagishi et al.				
	AU	2005/0103268	5/2005	Nishimoto et al.				
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INVENTORS: Gary ESCHER, et al.

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250583US6YADIV	10/803,994	03/19/04	2004/0173155	Shinya NISHIMOTO, et al.	PC226A (parent) / USP032104 (parent)
226277US6YA	10/259,306	09/30/02	2004/0060656	Hidehito SAIGUSA, et al.	PC227A
233240WO6	PCT/US2004/006080	03/18/04	WO 2004/095532	Gary ESCHER, et al.	PC6036A
277605US	10/550,215	09/22/05	None	Gary ESCHER, et al.	PC6036A

^{*}Present Application; listed for information SPW/EDG/aaf

235015WO6	PCT/US2004/006077	03/17/04	WO 2004/095530	Gary ESCHER, et al.	PC6037A
277634US6YA*	10/550,416	09/23/05	None	Gary ESCHER, et al.	PC6037A
PER CLIENT	10/450,094	12/15/03	2004/0081746	Kosuke IMAFUKU	UNKNOWN
200633US2	09/731,722	12/08/00	2001/0003271	Hayashi OTSUKI	6MN- 00S0860-1
238231US2CONT	10/444,957	05/27/03	2003/0200929	Hayashi OTSUKI	6MN- 00S0860-1C
246070US2	10/722,602	11/28/03	2004/0216667	Kouji MITSUHASHI	PA310014/ TKE/US-JH
PER CLIENT	6,783,863	08/31/04		Yoshio HARADA, et al.	UNKNOWN
PER CLIENT	6,884,516	04/26/05		Yoshio HARADA, et al.	UNKNOWN
PER CLIENT	11/072,448	03/07/05			UNKNOWN

^{*}Present Application; listed for information SPW/EDG/aaf

APPENDIX A

U.S. Application Serial No. 10/259,757 filed September 30, 2002, now U.S.

Publication No. 2004/0061447 (listed on attached PTO-1449) and corresponding PCT Application Serial No. PCT/IB03/04666 filed September 29, 2003 (International Search Report mailed June 9, 2004 attached), now PCT Publication No. WO 2004/030011 (listed on attached PTO-1449). Cited references listed on International Search Report were filed with the U.S. Patent and Trademark Office on June 28, 2004, in Application Serial No. 10/550,416.

U.S. Application Serial No. 10/259,858 filed September 30, 2002 (Office Action citing non-English language references and mailed December 22, 2004 attached), now U.S. Publication No. 2004/0060661 (listed on attached PTO-1449) and corresponding PCT Application Serial No. PCT/IB03/04923 filed September 29, 2003 (International Search Report mailed July 23, 2004 attached), now PCT Publication No. WO 2004/030020 (listed on attached PTO-1449).

U.S. Application Serial No. 10/259,382 filed September 30, 2002, now U.S. Patent No. 6,837,966 (listed on attached PTO-1449), corresponding PCT Application Serial No. PCT/IB03/04943 filed September 29, 2003 (International Search Report mailed July 15, 2004 attached), now PCT Publication No. WO 2004/030013 (listed on attached PTO-1449) and corresponding continuation application U.S. Application Serial No. 11/010,373 filed December 14, 2004, now U.S. Publication No. 2005/0103268 (listed on attached PTO-1449).

U.S. Application Serial No. 10/259,380 filed September 30, 2002 (Office Action citing non-English language references and mailed November 4, 2004 attached), now U.S. Publication No. 2004/0063333 (listed on attached PTO-1449) and corresponding PCT Application Serial No. PCT/IB03/05249 filed September 29, 2003 (International Search Report mailed April 15, 2004 attached), now PCT Publication No. WO 2004/030015 (listed on attached PTO-1449).

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*U.S. Application Serial No. 10/550,416, filed September 23, 2005, corresponding PCT Application Serial No. PCT/US2004/006077 filed March 17, 2004 (International Search Report and Written Opinion mailed November 15, 2004 attached), now PCT Publication No. WO 2004/095530 (listed on attached PTO-1449).

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now U.S. Patent No. 6,884,516 (listed on attached PTO-1449) and corresponding

continuation application U.S. Application Serial No. 11/072,448 filed March 7, 2005,

corresponding national stage EPO 00979084 (European Search Report, dated June 3,

2005, attached).

*Present Application family; listed for information

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